



Lab Manual



Chapter 4.4

Standard g-line Photoresist Processes

Standardized g-Line Photoresists at the Marvell Nanofabrication Laboratory		
	Dow Chemical S1818	FujiFilm OCG 825 35CS
Thickness Range:	1.5 – 2.2 μm	1 – 2.2 μm
Spin Coat Spin Speed (RPM): Time: Dispense:	(headway1 & 2) 5500 30 sec. Static or Dynamic	(svgcoat1 & 2) 5000, 2200 30 sec. Dynamic - 500RPM
Thickness:	1.65 μm	1.3, 2.0 μm
Prebake (soft bake) Temp: Time:	Manual Hotplate 110 $^{\circ}\text{C}$ 45 sec. Or vwr2 or Oven 95 $^{\circ}\text{C}$ 30 min.	(hotplate on svgcoat1, 2 & 3) 90 $^{\circ}\text{C}$ 60 sec. Or vwr2 or Oven 95 $^{\circ}\text{C}$ 25 min.
Exposure Energy: Exp time:	(ksaligner, quintel, cannon) $\sim 150 \text{ mJ/cm}^2$ $\sim 2 \text{ sec}$	(gcaws2) 55- 65 mJ/cm^2 $\sim 0.54 \text{ sec. g-line}$ $\sim 0.65 \text{ sec. i-line}$
Post Exposure Bake (PEB) Program: Bake Temp: Bake Time: Chill Time:	N/A	(hotplate on svgdev1 & 2) Program 2 (PEB) 120 $^{\circ}\text{C}$ 60 sec. 6 sec.
Develop Developer: Program: Method: Temp: Time:	(msink1&2) Microposit MF-319 N/A Manual Immersion 20 $^{\circ}\text{C}$ 60 sec.	(svgdev1 & 2) OCG 934 3:2 (premixed) Program 2 Puddle 20 $^{\circ}\text{C}$ 50 sec. (2x25 sec.)
Rinse Method: Time:	(msink1 & 2) Manual Immersion 60 sec.	(svgdev1 & 2) Automated 40 sec.

Dry Method: Time:	(srdmsink1) Automated Rinse /Dry 5 min.	(svgdev1 & 2) Automated 20 sec.
Hard Bake Method: Temp: Time: or UV Bake Method: Temp: Time:	(vwr2 or oven) Oven 115 °C 30 min. or Refer to UV bake System recipes (Chapter 4.34) (Chapter 4.35)	(vwr2 or oven) Oven 120 °C 30 min. or Refer to UV bake System recipes (Chapter 4.34) (Chapter 4.35)
Strip Stripper: Method: Temp: Time:	(msink1) PRS-3000 Bath 80 °C 5 min.	(msink1) PRS-3000 Bath 80 °C 5 min.
Post Strip Rinse/Dry Method: Time:	(srdmsink1) Standard recipe Rinse /Dry 5 min.	(srdmsink1) Standard recipe Rinse /Dry 5 min.